Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/702,505	KWON, HAE WOOK	
Examiner	Art Unit	_
Toan C. To	3616	

SEARCHED					
Class	Subclass	Date	Examiner		
280	732	12/5/2005	тт		
280	739	12/5/2005	TT		
280	743.1	12/5/2005	π		
280	743.2	12/5/2005	π		
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TMI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Text search (see noted search)	12/5/2005	π